INTERNATIONAL STANDARD

ISO/IEC 10373-7

Second edition 2008-05-01

Identification cards — Test methods —

Part 7: Vicinity cards

Cartes d'identification — Méthodes d'essai — Partie 7: Cartes de voisinage

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Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organization to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work. In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC 1.

International Standards are drafted in accordance with the rules given in the ISO/IEC Directives, Part 2.

The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO and IEC shall not be held responsible for identifying any or all such patent rights.

ISO/IEC 10373-7 was prepared by Joint Technical Committee ISO/IEC JTC 1, *Information technology*, Subcommittee SC 17, *Cards and personal identification*. A RD PREVIEW

This second edition cancels and replaces the first edition (ISO/IEC 10373-7:2001), Clause 5 and subclause 6.3.5 of which have been technically revised.

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ISO/IEC 10373 consists of the following parts, under the general title *Identification cards* — *Test methods*:

- Part 1: General characteristics
- Part 2: Cards with magnetic stripes
- Part 3: Integrated circuit(s) cards with contacts and related interface devices
- Part 5: Optical memory cards
- Part 6: Proximity cards
- Part 7: Vicinity cards

Identification cards — Test methods —

Part 7:

Vicinity cards

1 Scope

ISO/IEC 10373 defines test methods for characteristics of identification cards according to the definition given in ISO/IEC 7810. Each test method is cross-referenced to one or more base standards, which may be ISO/IEC 7810 or one or more of the supplementary standards that define the information storage technologies employed in identification card applications.

NOTE 1 Criteria for acceptability do not form part of ISO/IEC 10373, but will be found in the International Standards mentioned above.

NOTE 2 Test methods defined in ISO/IEC 10373 are intended to be performed separately. A given card is not required to pass through all the tests sequentially.

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This part of ISO/IEC 10373 deals with test methods, which are specific to contactless integrated circuit card (vicinity card) technology. ISO/IEC 10373-1 deals with test methods which are common to one or more ICC technologies and other parts deal with other technology-specific tests.

Unless otherwise specified, the tests in this part of ISO/IEC 10373 apply exclusively to vicinity cards defined in ISO/IEC 15693-1 and ISO/IEC 15693-2 catalog standards/sist/510845b5-a2c0-461c-8/e8-10373-7-2008

2 Normative reference(s)

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO/IEC 7810, Identification cards — Physical characteristics

ISO/IEC 15693-1, Identification cards — Contactless integrated circuit(s) cards — Vicinity cards — Part 1: Physical characteristics

ISO/IEC 15693-2:2006, Identification cards — Contactless integrated circuit cards — Vicinity cards — Part 2: Air interface and initialization

ISO/IEC 15693-3, Identification cards — Contactless integrated circuit(s) cards — Vicinity cards — Part 3: Anticollision and transmission protocol

IEC 61000-4-2, Electromagnetic compatibility (EMC) — Part 4-2: Testing and measurement techniques — Electrostatic discharge immunity test

ISBN 92-67-10188-9, Guide to the Expression of Uncertainty in Measurement, ISO, 1993

3 Terms, definitions, symbols and abbreviated terms

3.1 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1.1

base standard

standard which the test method is used to verify conformance to

3.1.2

operate as intended

surviving the action of some potentially destructive influence to the extent that any integrated circuit present in the card continues to operate and show a response¹⁾ as defined in ISO/IEC 15693-3 which conforms to the base standard

NOTE If other technologies exist on the same card, they will operate as intended in accordance with their respective standard.

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test method

method for testing characteristics of identification cards for the purpose of confirming their compliance with International Standards

3.2 Symbols and abbreviated terms TANDARD PREVIEW

DUT device under test (standards.iteh.ai)

ESD electrostatic discharge ISO/IEC 10373-7:2008

fc frequency of the operating field dc9782758a44/iso-iec-10373-7-2008

fs1, fs2 frequencies of the subcarriers

 H_{max} maximum field strength of the VCD antenna field

 H_{\min} minimum field strength of the VCD antenna field

VCD vicinity coupling device

VICC vicinity card

4 Default items applicable to the test methods

4.1 Test environment

Unless otherwise specified, testing shall take place in an environment of temperature $23^{\circ}C \pm 3^{\circ}C$ ($73^{\circ}F \pm 5^{\circ}F$) and of relative humidity 40% to 60%.

¹⁾ This International Standard does not define any test to establish the complete functioning of integrated circuit(s) cards. The test methods require only that a minimum functionality be verified. This may, in appropriate circumstances, be supplemented by further, application specific functionality criteria which are not available in the general case.

4.2 Pre-conditioning

Where pre-conditioning is required by the test method, the identification cards to be tested shall be conditioned to the test environment for a period of 24 h before testing.

4.3 Default tolerance

Unless otherwise specified, a default tolerance of \pm 5% shall be applied to the quantity values given to specify the characteristics of the test equipment (e.g. linear dimensions) and the test method procedures (e.g. test equipment adjustments).

4.4 Spurious inductance

Resistors and capacitors should have negligible inductance.

4.5 Total measurement uncertainty

The total measurement uncertainty for each quantity determined by these test methods shall be stated in the test report.

Basic information is given in the "Guide to the Expression of Uncertainty in Measurement", ISBN 92-67-10188-9, ISO, 1993.

5 Static electricity tesh STANDARD PREVIEW

The purpose of this test is to check the behaviour of the VICC in relation to electrostatic discharge (ESD) exposure of the test sample. The VICC under test is exposed to a simulated electrostatic discharge (ESD, human body model) and its basic operation checked following the exposure.

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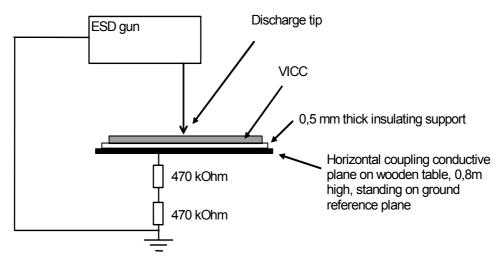


Figure 1 — ESD test circuit

5.1 Apparatus

Refer to IEC 61000-4-2.

a) Main specifications of the ESD generator:

— energy storage capacitance: 150 pF \pm 10%

— discharge resistance: 330 Ohm ± 10%

— charging resistance: between 50 MOhm and 100 MOhm

— rise time: 0,7 to 1 ns

b) Selected specifications from the optional items:

— type of equipment: table top equipment

discharge method: direct application of air discharge to the equipment under test

discharge electrodes of the ESD generator: round tip probe of 8 mm diameter

5.2 Procedure

Connect the test apparatus as specified in IEC 61000-4-2.

Apply the discharge successively in normal polarity to each of the 20 test zones shown in Figure 2. Then repeat the same procedure with reversed polarity. Allow a cool-down period between successive pulses of at least 10 s.

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WARNING — If the VICC includes contacts, the contacts shall be face up and the zone which includes contacts shall not be exposed to this discharge of the contacts shall not be exposed to this discharge of the contacts shall not be exposed to this discharge of the contacts shall be face up and the zone which includes contacts shall be face up and the zone which includes contacts shall be face up and the zone which includes contacts shall be face up and the zone which includes contacts shall be face up and the zone which includes contacts shall be face up and the zone which includes contacts shall not be exposed to this discharge of the contacts shall be face up and the zone which includes contacts shall not be exposed to this discharge of the contacts are contacts.

Check that the VICC operates as intended at the end of the test of

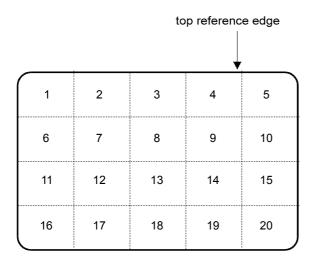


Figure 2 — Test zones on VICC for ESD test

5.3 Test report

The test report shall state whether or not the VICC operates as intended.

6 Test apparatus and test circuits

This clause defines the test apparatus and test circuits for verifying the operation of a VICC or a VCD according to ISO/IEC 15693-2. The test apparatus includes:

- calibration coil (see 6.1),
- test VCD assembly (see 6.2),
- reference VICC (see 6.3),
- digital sampling oscilloscope (see 6.4).

6.1 Calibration coil

This subclause defines the size, thickness and characteristics of the calibration coil.

6.1.1 Size of the calibration coil card

The calibration coil card consists of an area, which has the height and width defined in ISO/IEC 7810 for ID-1 type containing a single turn coil concentric with the card outline.



Figure 3 — Calibration coil

6.1.2 Thickness and material of the calibration coil card

The thickness of the calibration coil card shall be 0,76 mm $\pm 10\%$. It shall be constructed of a suitable insulating material.

6.1.3 Coil characteristics

The coil on the calibration coil card shall have one turn. The outer size of the coil shall be 72 mm (\pm 2%) \times 42 mm (\pm 2%) with corner radius 5 mm.

NOTE 1 The area over which the field is integrated is approximately 3000 mm².

The coil is made as a printed coil on PCB plated with 35 μ m copper. Track width shall be 500 μ m \pm 20%. The size of the connection pads shall be 1,5 mm \times 1,5 mm.

NOTE 2 At 13,56 MHz the approximate inductance is 200 nH and the approximate resistance is 0,25 Ohm.

A high impedance oscilloscope probe (e.g. >1MOhm, <14pF) shall be used to measure the (open circuit) voltage in the coil. The resonance frequency of the whole set (calibration coil, connecting leads and probe) shall be above 60 MHz.

NOTE 3 A parasitic capacitance of the probe assembly of less than 35 pF normally ensures a resonant frequency for the whole set of greater than 60 MHz.

The open circuit calibration factor for this coil is 0,32 V (rms) per A/m (rms) [Equivalent to 900 mV (peak-to-peak) per A/m (rms)].

6.2 Test VCD assembly

The test VCD assembly for load modulation consists of a 150 mm diameter VCD antenna and two parallel sense coils: sense coil a and sense coil b. The test set-up is shown in Figure 4. The sense coils are connected such that the signal from one coil is in opposite phase to the other. The 10 Ohm potentiometer P1 serves to fine adjust the balance point when the sense coils are not loaded by a VICC or any magnetically coupled circuit. The capacitive load of the probe including its parasitic capacitance shall be less than 14 pF.

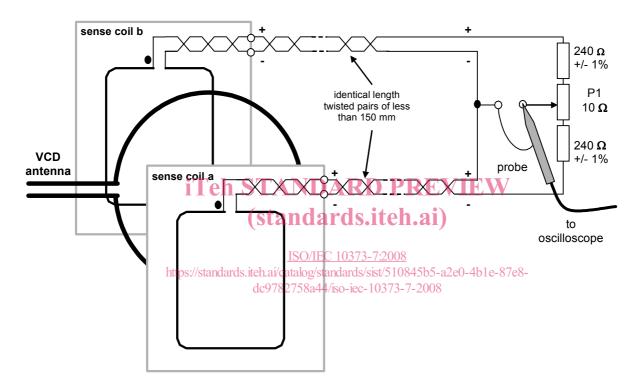


Figure 4 — Test set-up

The maximum length of 150 mm of the twisted pairs takes the wider spacing of the sense coils in comparison to the set-up in ISO/IEC 10373-6 into account.

In order to avoid any unintended misalignment in case of an unsymmetrical set-up the tuning range of the potentiometer P1 is only 10 Ω . If the set-up cannot be compensated by the 10 Ω potentiometer P1 the overall symmetry of the set-up should be checked.

The capacitance of the connections and oscilloscope probe should be kept to a minimum for reproducibility.

The high impedance oscilloscope probe ground connection should be as short as possible, less than 20 mm or coaxial connection.

6.2.1 Test VCD antenna

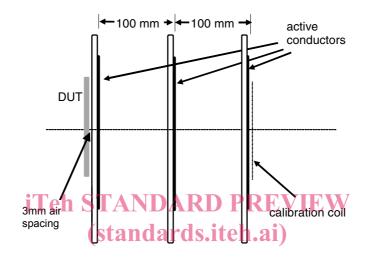
The Test VCD antenna shall have a diameter of 150 mm and its construction shall conform to the drawings in Annex A. The tuning of the antenna may be accomplished with the procedure given in Annex B.

6.2.2 Sense coils

The size of the sense coils is 100×70 mm. The sense coil construction shall conform to the drawings in Annex C.

6.2.3 Assembly of test VCD

The sense coils and test VCD antenna are assembled parallel and with the sense and antenna coils coaxial and such that the distance between the active conductors is 100 mm as in Figure 5. The distance between the coil in the DUT and the calibration coil shall be equal with respect to the coil of the test VCD antenna.



sense coil a ISQVED 10373-7:20 sense coil b https://standards.iteh.ai/catalantennards/sist/510845b5-a2e0-4b1e-87e8-dc9782758a44/iso-iec-10373-7-2008

NOTE The distance of 100 mm reflects larger read distance and 3mm air spacing avoids parasitic effects such as detuning by closer spacing or ambiguous results due to noise and other environmental effects.

Figure 5 — Test VCD assembly

6.3 Reference VICCs

Reference VICCs are defined

- to test H_{min} and H_{max} produced by a VCD (under conditions of loading by a VICC),
- to test the ability of a VCD to power a VICC,
- to detect the minimum load modulation signal from the VICC.

6.3.1 Reference VICC for VCD power

The schematic for the power test is shown in Annex D. Power dissipation can be set by the resistor R1 or R2 respectively in order to measure H_{max} and H_{min} as defined in 8.1.2. The resonant frequency can be adjusted with C2.

6.3.2 Reference VICC for load modulation test

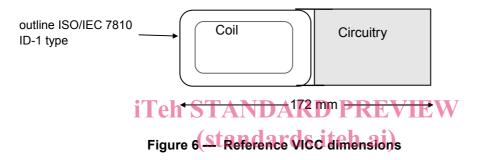
A suggested schematic for the load modulation test is shown in Annex E. The load modulation can be chosen to be resistive or reactive.

This reference VICC is calibrated by using the Test VCD assembly as follows:

The reference VICC is placed in the position of the DUT. The load modulation signal amplitude is measured as described in 7.2. This amplitude should correspond to the minimum amplitude at all values of field strength required by the base standard.

6.3.3 Dimensions of the reference VICCs

The reference VICCs consist of an area containing the coils which has the height and width defined in ISO/IEC 7810 for ID-1 type. An area external to this, containing the circuitry which emulates the required VICC functions, is appended in a way as to allow insertion into the test set-ups described below and so as to cause no interference to the tests. The dimensions shall be as in Figure 6.



6.3.4 Thickness of the reference VICC board SO/IEC 10373-7:2008

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The thickness of the reference VICC active area shall be 0,76 mm/±10%.08

6.3.5 Coil characteristics

The coil in the active area of the reference VICC shall have 4 turns and shall be concentric with the area outline.

The outer size of the coils shall be 72 mm \pm 2% x 42 mm \pm 2%.

The coil is printed on PCB plated with 35 µm copper.

Track width and spacing shall be 500 μ m \pm 20%.

NOTE At 13,56 MHz the nominal inductance is 3,5 µH and the nominal resistance is 1 Ohm.

6.4 Digital sampling oscilloscope

The digital sampling oscilloscope shall be capable of sampling at a rate of at least 100 million samples per second with a resolution of at least 8 bits at optimum scaling. The oscilloscope should have the capability to output the sampled data as a text file to facilitate mathematical and other operations such as windowing on the sampled data using external software programmes (Annex F).